Application/Control No. Applicant(s)/Patent Under Reexamination 09/838,206 YOSHIDA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Kristin Derwich 2132 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,930,367 07-1999 Osawa et al. 705/57 Α В US-US-С US-D US-Ε US-F US-G US-Н ī US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) υ V W

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